Search Notes

Application No.	Applicant(s)	
10/627,218	YEO ET AL.	
Examiner	Art Unit	
Nauven T Ha	2831	

	SEAR	CHED	
Class	Subclass	Date	Examiner
361	302	11/3/04	.04
	303		
	305		
	381.1		
	301.5		
	34.1		
	321.3		
	3215		
	306.1		
	306.3		
	311		
	313		
47	402		
	403		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	
_	1		

(INCLUDING SEAR		
	DATE	EXMR
·		
•		
·		